Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,369	CHENG ET AL.	
Examiner	Art Unit	
Anthony Weier	1761	

	·				
	SEARCHED				
Class	Subclass	Date	Examiner		
updated	previous search along with				
426	594, 597				
,	115, 119	11/17/2006	AW		
			_		
			<del>-</del>		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
99	594		
222	137,145.8		
426	594, 597		
426/115, 119		11/17/2006	AW

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PGPubText Search	11/17/2006	AW	
		<del>-</del>	